

Notice of References Cited	Application/Control No. 10/562,550		Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
	Examiner CRYSTAL I. LEACH		Art Unit 3737	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,217,909 A	08-1980	Papadofrangakis et al.	600/441
*	B	US-4,688,428 A	08-1987	Nicolas, Jean-Marie	73/602
*	C	US-5,220,923 A	06-1993	Hagiwara et al.	600/455
*	D	US-5,415,172 A	05-1995	Tannaka et al.	600/437
*	E	US-5,840,028 A	11-1998	Chubachi et al.	600/437
*	F	US-6,258,031 B1	07-2001	Sunagawa et al.	600/443
*	G	US-2003/0009101 A1	01-2003	Sunagawa et al.	600/437
*	H	US-2003/0199762 A1	10-2003	Fritz et al.	600/437
*	I	US-6,770,034 B2	08-2004	Sunagawa et al.	600/443
*	J	US-2004/0260180 A1	12-2004	Kanai et al.	600/449
*	K	US-2007/0123777 A1	05-2007	Watanabe et al.	600/437
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.